Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/685,538	CHUN LIU ET AL.	
Examiner	**Art Unit**	
John D. Lee	2874	

SEARCHED			
Class	Subclass	Date	Examiner
359	326-332, 344	10/19/2005	JDL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPTO "WEST" Database searched; search strategy on separate sheet.	10/19/2005	JDL